

## **MOSFET**

## OptiMOS<sup>™</sup>5 Power-Transistor, 60 V

### **Features**

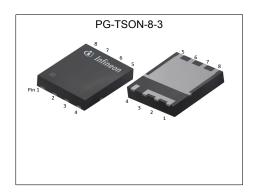
- Optimized for synchronous rectification
- 100% avalanche tested
- Superior thermal resistance
- N-channel
- 175°C rated
- Pb-free lead plating; RoHS compliant
- Halogen-free according to IEC61249-2-21
  Higher solder joint reliability due to enlarged source interconnection

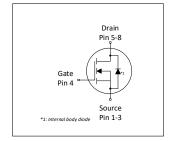
## **Product validation**

Fully qualified according to JEDEC for Industrial Applications

**Kev Performance Parameters** Table 1

Table 1 Hoy 1 of termination 1 arameters								
Parameter	Value	Unit						
V <sub>DS</sub>	60	V						
R <sub>DS(on),max</sub>	1.05	mΩ						
$I_{D}$	330	A						
Qoss	123	nC						
Q <sub>G</sub> (0V10V)	115	nC						











Type / Ordering Code	Package	Marking	Related Links
ISC010N06NM5	PG-TSON-8-3	010N06N	-

# OptiMOS<sup>TM</sup>5 Power-Transistor, 60 V ISC010N06NM5



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## OptiMOS<sup>™</sup>5 Power-Transistor, 60 V ISC010N06NM5



# 1 Maximum ratings at $T_A$ =25 °C, unless otherwise specified

Table 2 Maximum ratings

Dougueston	0 b a l	Values				Note / Took Coundition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Continuous drain current <sup>1)</sup>	I <sub>D</sub>	- - -	- - -	330 233 39	A	$V_{\rm GS}$ =10 V, $T_{\rm C}$ =25 °C $V_{\rm GS}$ =10 V, $T_{\rm C}$ =100 °C $V_{\rm GS}$ =10 V, $T_{\rm A}$ =25 °C, $R_{\rm thJA}$ =50 °C/W <sup>2)</sup>
Pulsed drain current <sup>3)</sup>	I <sub>D,pulse</sub>	-	-	1320	Α	<i>T</i> <sub>C</sub> =25 °C
Avalanche energy, single pulse <sup>4)</sup>	<b>E</b> AS	-	-	911	mJ	$I_{\rm D}$ =50 A, $R_{\rm GS}$ =25 $\Omega$
Gate source voltage	V <sub>GS</sub>	-20	-	20	V	-
Power dissipation	P <sub>tot</sub>	-	-	214 3.0	W	T <sub>C</sub> =25 °C T <sub>A</sub> =25 °C, R <sub>thJA</sub> =50 °C/W <sup>2)</sup>
Operating and storage temperature	e $T_{j}, T_{stg}$	-55	-	175	°C	IEC climatic category; DIN IEC 68-1 55/175/56

#### 2 Thermal characteristics

Table 3 **Thermal characteristics** 

Parameter	Values				Linit	Note / Test Condition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Thermal resistance, junction - case, bottom	R <sub>thJC</sub>	-	0.35	0.7	°C/W	-
Thermal resistance, junction - case, top	R <sub>thJC</sub>	-	-	20	°C/W	-
Device on PCB, 6 cm² cooling area²)	R <sub>thJA</sub>	-	-	50	°C/W	-

<sup>&</sup>lt;sup>1)</sup> Rating refers to the product only with datasheet specified absolute maximum values, maintaining case temperature as specified. For other case temperatures please refer to Diagram 2. De-rating will be required based on the actual environmental conditions.  $^{2)}$  Device on 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm $^{2}$  (one layer, 70  $\mu$ m thick) copper area for drain

connection. PCB is vertical in still air.

3) See Diagram 3 for more detailed information

4) See Diagram 13 for more detailed information

## OptiMOS<sup>™</sup>5 Power-Transistor, 60 V ISC010N06NM5



# 3 Electrical characteristics at $T_j$ =25 °C, unless otherwise specified

Table 4 **Static characteristics** 

Davamatav	0		Values			
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	60	-	-	V	V <sub>GS</sub> =0 V, I <sub>D</sub> =1 mA
Gate threshold voltage	V <sub>GS(th)</sub>	2.1	2.8	3.3	V	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 147  \mu {\rm A}$
Zero gate voltage drain current	I <sub>DSS</sub>	-	0.5 10	1 100	μΑ	V <sub>DS</sub> =60 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =25 °C V <sub>DS</sub> =60 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =125 °C
Gate-source leakage current	$I_{\mathrm{GSS}}$	-	10	100	nA	V <sub>GS</sub> =20 V, V <sub>DS</sub> =0 V
Drain-source on-state resistance	R <sub>DS(on)</sub>	-	0.87 1.23	1.05 1.45	mΩ	V <sub>GS</sub> =10 V, I <sub>D</sub> =50 A V <sub>GS</sub> =6 V, I <sub>D</sub> =12.5 A
Gate resistance	R <sub>G</sub>	-	2.2	3.3	Ω	-
Transconductance <sup>1)</sup>	<b>g</b> fs	85	170	-	S	$ V_{DS}  \ge 2 I_D R_{DS(on)max}, I_D = 50 A$

Table 5 **Dynamic characteristics** 

Davamatav	Crossball	Values			11	Nata / Tant Candition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Input capacitance	C <sub>iss</sub>	-	8300	11000	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =30 V, <i>f</i> =1 MHz
Output capacitance <sup>1)</sup>	Coss	-	1800	2300	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =30 V, <i>f</i> =1 MHz
Reverse transfer capacitance <sup>1)</sup>	C <sub>rss</sub>	-	71	120	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =30 V, <i>f</i> =1 MHz
Turn-on delay time	$t_{\sf d(on)}$	-	11	-	ns	$V_{\rm DD}$ =30 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =50 A, $R_{\rm G,ext}$ =1.6 $\Omega$
Rise time	t <sub>r</sub>	-	15	-	ns	$V_{\rm DD}$ =30 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =50 A, $R_{\rm G,ext}$ =1.6 $\Omega$
Turn-off delay time	$t_{\sf d(off)}$	-	54	-	ns	$V_{\rm DD}$ =30 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =50 A, $R_{\rm G,ext}$ =1.6 $\Omega$
Fall time	t <sub>f</sub>	-	31	-	ns	$V_{\rm DD}$ =30 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =50 A, $R_{\rm G,ext}$ =1.6 $\Omega$

Table 6 Gate charge characteristics<sup>2)</sup>

Parameter	O. mak al		Values			
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Gate to source charge	Q <sub>gs</sub>	-	35	-	nC	$V_{\rm DD}$ =30 V, $I_{\rm D}$ =50 A, $V_{\rm GS}$ =0 to 10 V
Gate charge at threshold	$Q_{g(th)}$	-	23	-	nC	$V_{\rm DD}$ =30 V, $I_{\rm D}$ =50 A, $V_{\rm GS}$ =0 to 10 V
Gate to drain charge <sup>1)</sup>	Q <sub>gd</sub>	-	21	31	nC	$V_{\rm DD}$ =30 V, $I_{\rm D}$ =50 A, $V_{\rm GS}$ =0 to 10 V
Switching charge	Q <sub>sw</sub>	-	32	-	nC	$V_{\rm DD}$ =30 V, $I_{\rm D}$ =50 A, $V_{\rm GS}$ =0 to 10 V
Gate charge total <sup>1)</sup>	Qg	-	115	143	nC	$V_{\rm DD}$ =30 V, $I_{\rm D}$ =50 A, $V_{\rm GS}$ =0 to 10 V
Gate plateau voltage	V <sub>plateau</sub>	-	4.2	-	V	$V_{\rm DD}$ =30 V, $I_{\rm D}$ =50 A, $V_{\rm GS}$ =0 to 10 V
Gate charge total, sync. FET	Q <sub>g(sync)</sub>	-	102	-	nC	V <sub>DS</sub> =0.1 V, V <sub>GS</sub> =0 to 10 V
Output charge <sup>1)</sup>	Qoss	-	123	163	nC	V <sub>DS</sub> =30 V, V <sub>GS</sub> =0 V

 $<sup>^{1)}</sup>$  Defined by design. Not subject to production test.  $^{2)}$  See "Gate charge waveforms" for parameter definition

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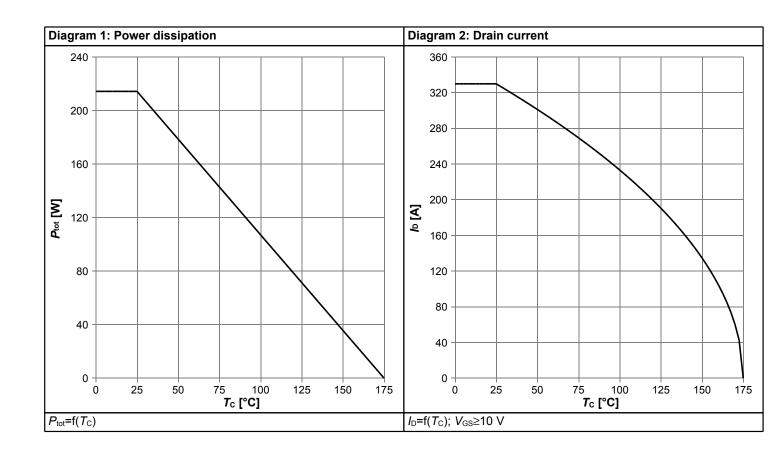


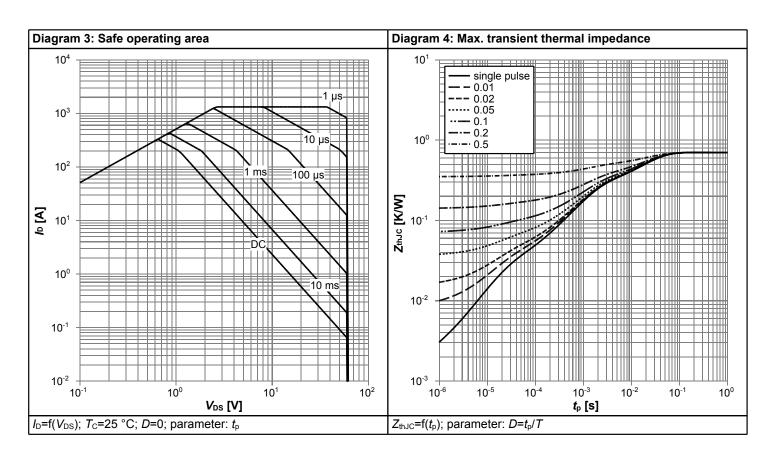
## Table 7 Reverse diode

Develope	Cumbal		Values			Nata (Tant Oan dittan
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Diode continuous forward current	Is	-	-	151	Α	<i>T</i> <sub>C</sub> =25 °C
Diode pulse current	I <sub>S,pulse</sub>	-	-	1320	Α	<i>T</i> <sub>C</sub> =25 °C
Diode forward voltage	V <sub>SD</sub>	-	0.82	1.2	V	V <sub>GS</sub> =0 V, I <sub>F</sub> =50 A, T <sub>j</sub> =25 °C
Reverse recovery time <sup>1)</sup>	<i>t</i> <sub>rr</sub>	-	41	82	ns	V <sub>R</sub> =30 V, I <sub>F</sub> =50 A, d <i>i</i> <sub>F</sub> /d <i>t</i> =100 A/μs
Reverse recovery charge <sup>1)</sup>	Qrr	-	170	340	nC	V <sub>R</sub> =30 V, I <sub>F</sub> =50 A, d <i>i</i> <sub>F</sub> /d <i>t</i> =100 A/μs

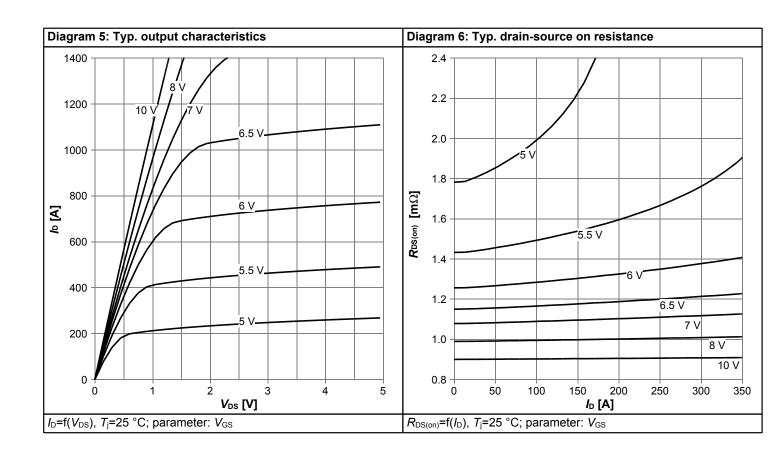


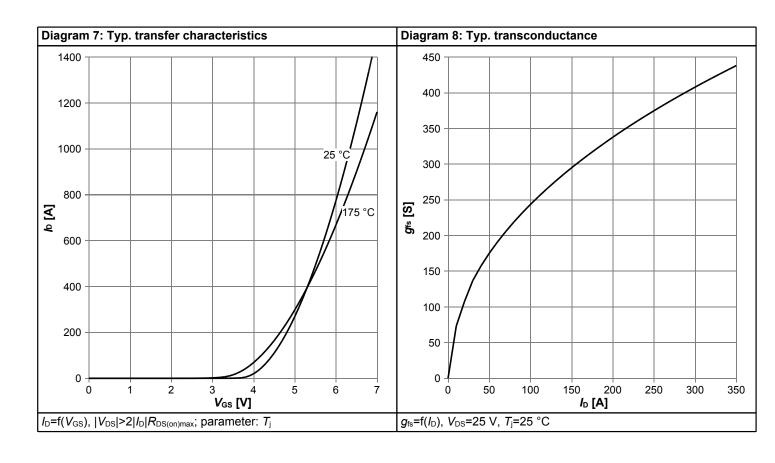
## 4 Electrical characteristics diagrams



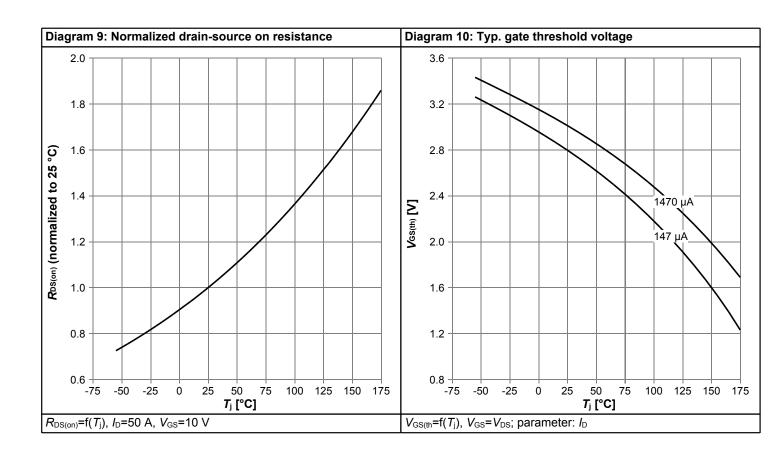


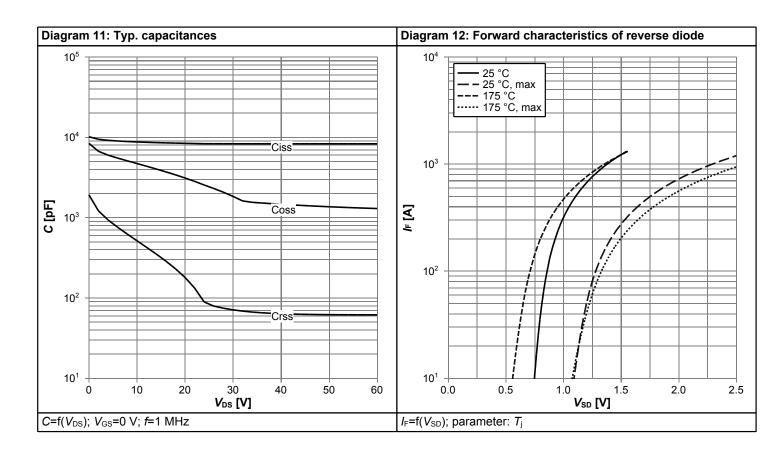




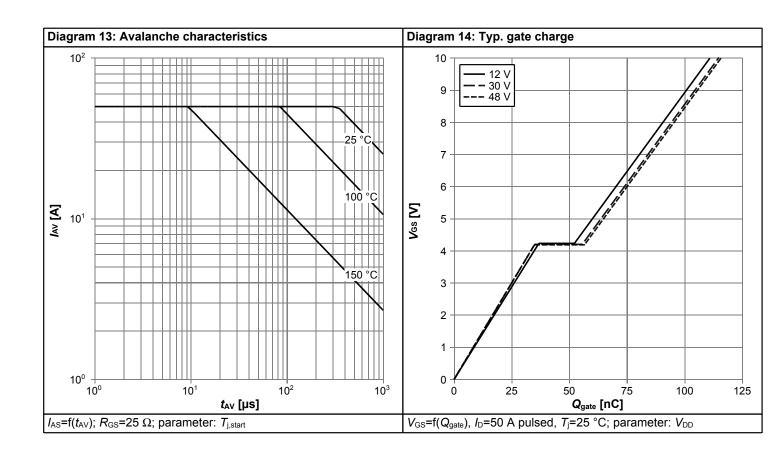


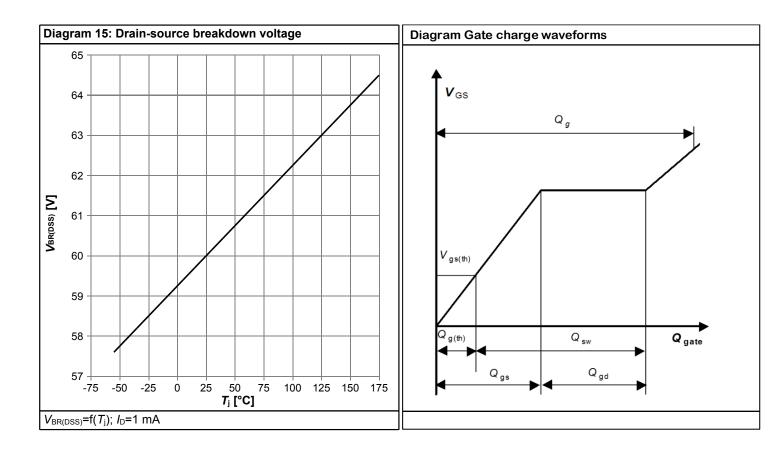






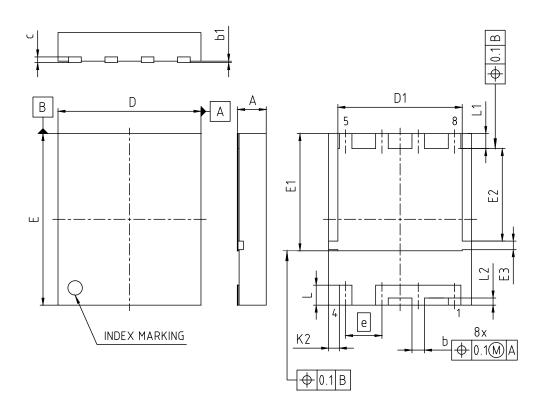








# 5 Package Outlines



DIMENSION	MILLIM	IETERS			
DIMENSION	MIN.	MAX.			
Α	=	1.10			
b	0.34	0.54			
b1	=	0.05			
С	0.	20			
D	4.90	5.10			
D1	4.25	4.45			
E	5.90	6.10			
E1	4.00	4.20			
E2	3.14	3.34			
E3	0.20	0.40			
е	1.27				
K2	(0.37)				
L	0.60	0.80			
L1	0.43	0.63			
L2	(0.25)				

<b>DOCUMENT NO.</b> Z8B00187559			
REVISION 01			
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EUROPEAN PROJECTION			
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Figure 1 Outline PG-TSON-8-3, dimensions in mm/inches

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### **Revision History**

ISC010N06NM5

Revision: 2021-08-27, Rev. 2.0

Previous Revision

Revision	Date	Subjects (major changes since last revision)				
2.0	2021-08-27	Release of final version				

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